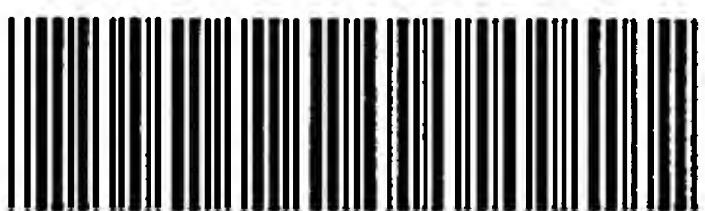


## **Search Notes**



**Application/Control No.**

10/709,290

**Examiner**

Daniel F. Hajnik

**Applicant(s)/Patent under  
Reexamination**

EPSTEIN ET AL.

## Art Unit

2671

**SEARCHED**

# SEARCH NOTES (INCLUDING SEARCH STRATEGY)

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner